

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 242278US2S DIV	SERIAL NO. 10/662,309 New Application		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT					
		Ryo FUKUDA		FILING DATE Herewith		GROUP Unassigned	2824
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
TL	AA	2002/0120895 A1	08/02	Suzuki			
TL	AB	2001/0047499 A1	11/01	Whetsel, JR			
TL	AC	6,445,627	09/02	Nakahara et al			
TL	AD	6,408,414	06/02	Hatada			
TL	AE	6,154,396	11/00	Yabe et al			
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO				YES	NO	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
TL	AW	Jun OHTANI, et al. "A Shared Built-In Self-Repair Analysis for Multiple Embedded Memories," IEEE 2001 CUSTOM INTEGRATED CIRCUITS CONFERENCE. 2001, pp.187-190					
	AX						
	AY						
	AZ				<input type="checkbox"/> Additional References sheet(s) attached		
Examiner		TOAN LE			Date Considered 8/19/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE  
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U.S. PATENT & TRADEMARK OFFICE

SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 242278US2SDIV	SHEET 1 OF 1		SERIAL NO. 10/662,309
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Ryo FUKUDA			
				FILING DATE September 16, 2003	GROUP 2818 2824		
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
TL	AO	6-66885	03/11/1994	Japan	YES	NO	X
TL	AP	2000-0059512	10/05/2000	Korea	YES	NO	X
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <u>TOAN IE</u>				Date Considered <u>8/19/05</u>			

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.